

STGB35N35LZ STGP35N35LZ

Automotive-grade 345 V internally clamped IGBT, EAS 450 mJ

Datasheet - production data

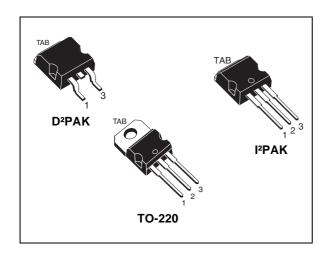
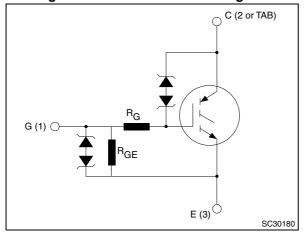


Figure 1. Internal schematic diagram



Features

- Designed for automotive applications and AEC-Q101 qualified
- Low threshold voltage
- Low on-voltage drop
- High voltage clamping feature
- · Logic level gate charge
- ESD gate-emitter protection
- · Gate and gate-emitter integrated resistors

Application

· Automotive ignition

Description

This application specific IGBT utilizes the most advanced PowerMESH™ technology. The built-in Zener diodes between gate-collector and gate-emitter provide overvoltage protection capabilities. The device also exhibits low on-state voltage drop and low threshold drive for use in automotive ignition system.

Table 1. Device summary

Order codes	Marking	Package	Packaging
STGB35N35LZ-1	GB35N35LZ	I²PAK	Tube
STGB35N35LZT4	GB35N35LZ	D²PAK	Tape and reel
STGP35N35LZ	GP35N35LZ	TO-220	Tube

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This is information on a product in full production.

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1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{CES}	Collector-emitter voltage (V _{GE} = 0)	V _{CES (clamped)}	V
V _{ECS}	Emitter collector voltage (V _{GE} = 0)	20	V
I _C ⁽¹⁾	Continuous collector current at T _C = 25 °C	40	А
I _C ⁽¹⁾	Continuous collector current at T _C = 100 °C	30	Α
I _{CP} (2)	Pulsed collector current	80	Α
V _{GE}	Gate-emitter voltage	V _{GE (clamped)}	V
P _{TOT}	Total dissipation at T _C = 25 °C	176	W
E _{AS}	Single pulse energy (T_C =25 °C, L=1.6 mH, I_C = 22 A, V_{CC} = 50 V)	450	mJ
	Human body model (R=1,5 kΩ, C=100 pF)	8	kV
ESD	Machine model (R=0, C=100 pF)	800	V
	Charged device model	2	kV
T _{stg}	Storage temperature	55 to 175	°C
T _j	Operating junction temperature	– 55 to 175	

1. Calculated according to the iterative formula:

$$I_{C}(T_{C}) = \frac{T_{j(max)} - T_{C}}{R_{thj-c} \times V_{CE(sat)(max)}(T_{j(max)}, I_{C}(T_{C}))}$$

2. Pulse width limited by maximum junction temperature

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	0.85	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	62.5	°C/W



2 Electrical characteristics

(T_i =25 °C unless otherwise specified)

Table 4. Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
	Collector emitter	I _C =2 mA,		345		V
V _{CES(clamped)}	clamped voltage (V _{GE} =0)	I _C =2 mA, T _j = - 40 °C to 150 °C	320		380	٧
V _{(BR)ECS}	Emitter collector break- down voltage (V _{GE} =0)	I _C = 75 mA	20	28		٧
$V_{GE(clamped)}$ Gate emitter clamped voltage $I_G = \pm 2 \text{ mA}$		I _G = ± 2 mA	12	14	16	٧
1	Collector cut-off current	V _{CE} = 15 V, T _j =150 °C			10	μΑ
I _{CES}	(V _{GE} = 0)	V _{CE} =200 V, T _j =150 °C			100	μΑ
I _{GES}	Gate-emitter leakage current ($V_{CE} = 0$) $V_{GE} = \pm 10 \text{ V}$		500	625	830	μΑ
R _{GE}	Gate emitter resistance		12	15	20	kΩ
R_{G}	Gate resistance			1.5		kΩ
		$V_{CE} = V_{GE}$, $I_{C} = 1$ mA, T_{j} =-40 °C	1.4			٧
V _{GE(th)}	Gate threshold voltage	V _{CE} =V _{GE} , I _C = 1 mA	1.2	1.6	2.3	V
		$V_{CE} = V_{GE}$, $I_C = 1$ mA, $T_j = 150$ °C	0.7			٧
V.	Collector-emitter	V _{GE} =4.5 V, I _C = 10 A		1.15	1.5	V
V _{CE(sat)}	saturation voltage	V _{GE} =4.5 V, I _C = 15 A		1.3	1.7	V

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{ies}	Input capacitance		-	700	-	pF
C _{oes}	Output capacitance	$V_{CE} = 25V, f = 1MHz,$	-	150	-	pF
C _{res}	Reverse transfer capacitance	V _{GE} = 0	-	6	-	pF
Qg	Gate charge	$V_{CE} = 280V, I_{C} = 15A, V_{GE} = 5V$	-	49	-	nC

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Table 6. Functional characteristics

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
U.I.S.	Functional test open secondary coil	$R_G = 0$, $T_j = 150$ °C, $V_{CC} = 50$ V, $V_{GE} = 5$ V, L=1.6 mH	18	-	-	Α

Table 7. Switching time

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
td(on)	Resistive load Turn-on delay time Rise time	$V_{CC} = 14 \text{ V},$ $R_L = 1 \Omega, V_{GE} = 5 \text{ V}$	-	1.1 7	-	µs µs
td(on)	Resistive load Turn-on delay time Rise time	$V_{CC} = 14 \text{ V},$ $R_L = 1 \Omega, V_{GE} = 5 \text{ V}$ $T_j = 150 \text{ °C}$	-	1 6.6	-	µs µs
t _{d(off)} t _f dv/dt	Inductive load Turn-off delay time Fall time Turn-off voltage slope	V _{CC} = 300 V, L = 1 mH I _C = 15 A, V _{GE} = 5 V	-	26.5 5.5 70	-	μs μs V/μs
t _{d(off)} t _f dv/dt	Inductive load Turn-off delay time Fall time Turn-off voltage slope	$V_{CC} = 300 \text{ V, L} = 1 \text{ mH}$ $I_{C} = 15 \text{ A, V}_{GE} = 5 \text{ V}$ $T_{j} = 150 \text{ °C}$	-	28 9 65	•	μs μs V/μs



2.1 Electrical characteristics (curves)

Figure 2. Collector-emitter saturation voltage vs temperature

Figure 3. Self clamped inductive switch

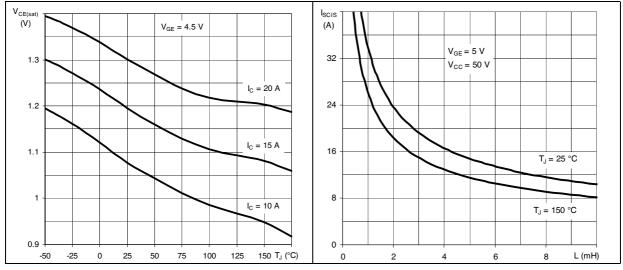
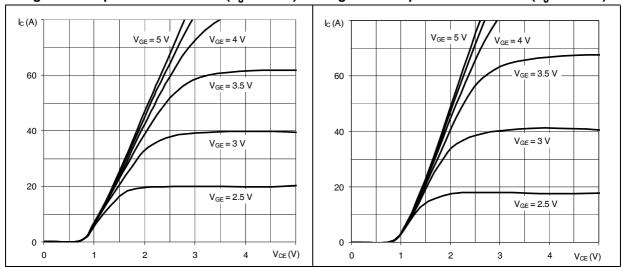


Figure 4. Output characteristics (T_J = 25 °C)

Figure 5. Output characteristics ($T_J = -40$ °C)



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Figure 6. Output characteristics ($T_J = 175$ °C)

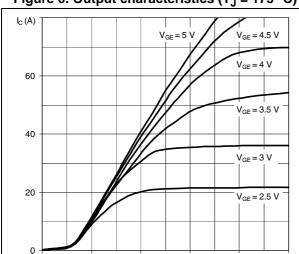


Figure 7. Transfer characteristics

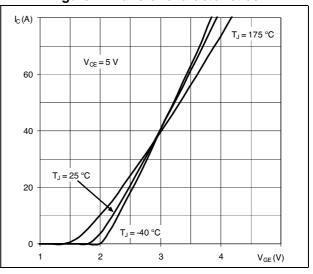


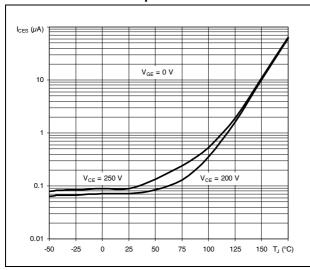
Figure 8. Collector cut-off current vs temperature

3

 $V_{CE}(V)$

2

Figure 9. Normalized collector emitter voltage vs temperature



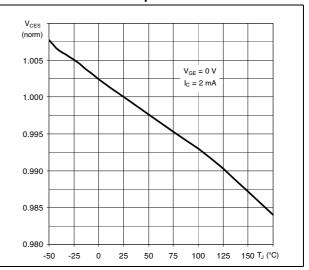
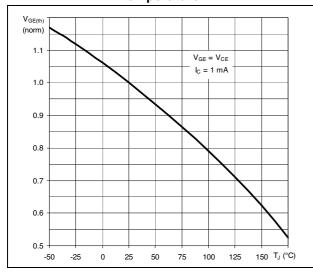


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Gate charge



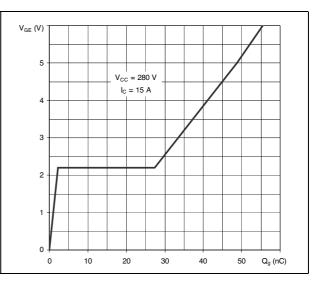
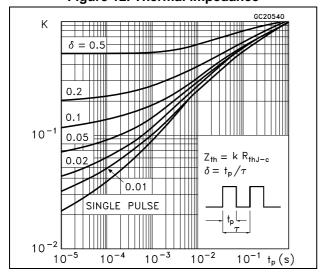


Figure 12. Thermal impedance



3 Test circuits

Figure 13. Test circuit for inductive load switching

Figure 14. Gate charge test circuit

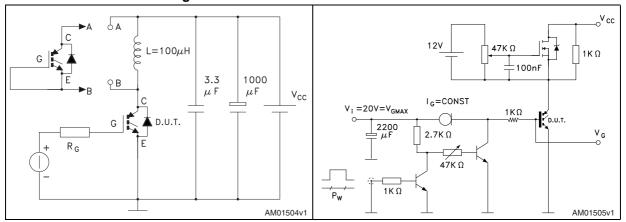
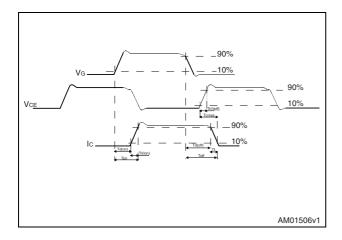


Figure 15. Switching waveform





4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Table 8. D²PAK (TO-263) mechanical data

Dim.		mm	
Dim.	Min.	Тур.	Max.
Α	4.40		4.60
A1	0.03		0.23
b	0.70		0.93
b2	1.14		1.70
С	0.45		0.60
c2	1.23		1.36
D	8.95		9.35
D1	7.50		
Е	10		10.40
E1	8.50		
е		2.54	
e1	4.88		5.28
Н	15		15.85
J1	2.49		2.69
L	2.29		2.79
L1	1.27		1.40
L2	1.30		1.75
R		0.4	
V2	0°		8°

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SEATING PLANE
COPLANARITY A1

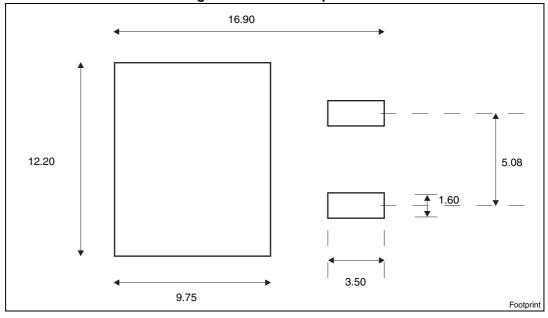
R

GAUGE PLANE
V2

0079457_T

Figure 16. D²PAK (TO-263) drawing





a. All dimension are in millimeters

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Table 9. I²PAK (TO-262) mechanical data

DIM.		mm.	
DIWI.	min.	typ	max.
Α	4.40		4.60
A1	2.40		2.72
b	0.61		0.88
b1	1.14		1.70
С	0.49		0.70
c2	1.23		1.32
D	8.95		9.35
е	2.40		2.70
e1	4.95		5.15
E	10		10.40
L	13		14
L1	3.50		3.93
L2	1.27		1.40

Figure 18. I²PAK (TO-262) drawing

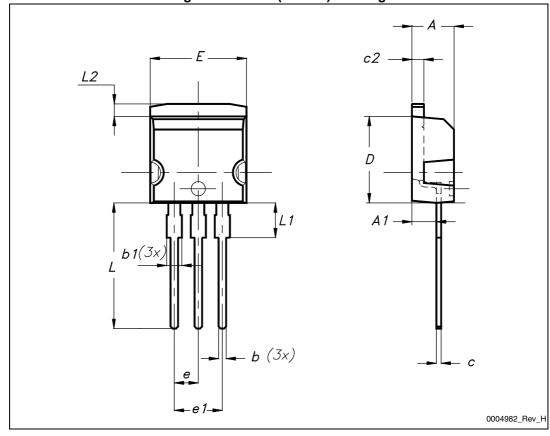


Table 10. TO-220 type A mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
А	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
С	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
е	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95



øΡ H1 D <u>D1</u> L20 L30 <u>L</u>1 b1(X3) b (X3) .e 1_ 0015988_typeA_Rev_T

Figure 19. TO-220 type A drawing

5 Packaging mechanical data

Table 11. D²PAK (TO-263) tape and reel mechanical data

Таре				Reel	
Dim.	m	m	Dim.	m	ım
Dim.	Min.	Max.	Dim.	Min.	Max.
A0	10.5	10.7	Α		330
В0	15.7	15.9	В	1.5	
D	1.5	1.6	С	12.8	13.2
D1	1.59	1.61	D	20.2	
Е	1.65	1.85	G	24.4	26.4
F	11.4	11.6	N	100	
K0	4.8	5.0	Т		30.4
P0	3.9	4.1			
P1	11.9	12.1		Base qty	1000
P2	1.9	2.1		Bulk qty	1000
R	50				
Т	0.25	0.35			
W	23.7	24.3			



Top cover tolerance on tape +/- 0.2 mm

Top cover tolerance on tape +/- 0.2 mm

For machine ref. only including draft and radii concentric around B0

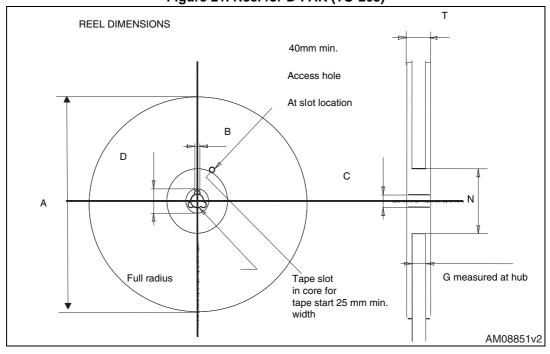
User direction of feed

Liser direction of feed

AM08852v1

Figure 20. Tape for D²PAK (TO-263)





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6 Revision history

Table 12. Document revision history

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Date	Revision	Changes
29-Mar-2006	1	Initial release.
03-Jun-2009	2	Document status promoted from preliminary data to datasheet.
05-Nov-2009	3	Inserted Chapter 2.1: Electrical characteristics (curves)
16-Feb-2010	4	Added new package, mechanical data: TO-220
03-Jun-2010	5	 Added Figure 12: Thermal impedance Modifed Figure 4, Figure 5, Figure 6 and Figure 7 D²PAK mechanical data has been updated
28-May-2013	6	- Updated title in cover page, Chapter 5: Packaging mechanical data and Chapter 5: Packaging mechanical data.



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